Search Notes			

Applicat	ion/Control No.	Applicant( Reexamina	s)/Patent under ation
10/759,1	59	PAROLKA	AR ET AL.
Examine	r	Art Unit	
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SEARCHED			
Class	Subclass	Date	Examiner
379	88.17	12/6/2007	ME
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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East Interfer	ence search	12/6/2007	ME

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East	12/6/2007	ME
Consulted with Fan Tsang	12/6/2007	ME
IEEE search	12/5/2007	ME
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